
**Information technology — Radio
frequency identification device
conformance test methods —**

Part 6:

**Test methods for air interface
communications at 860 MHz to 960 MHz**

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*Technologies de l'information — Méthodes d'essai de conformité du
dispositif d'identification de radiofréquence —*

*Partie 6: Méthodes d'essai pour des communications d'une interface
d'air à 860 MHz et jusqu'à 960 MHz*

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ISO copyright office
Case postale 56 • CH-1211 Geneva 20
Tel. + 41 22 749 01 11
Fax + 41 22 749 09 47
E-mail copyright@iso.org
Web www.iso.org

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Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

In exceptional circumstances, the joint technical committee may propose the publication of a Technical Report of one of the following types:

- type 1, when the required support cannot be obtained for the publication of an International Standard, despite repeated efforts;
- type 2, when the subject is still under technical development or where for any other reason there is the future but not immediate possibility of an agreement on an International Standard;
- type 3, when the joint technical committee has collected data of a different kind from that which is normally published as an International Standard ("state of the art", for example).

Technical Reports of types 1 and 2 are subject to review within three years of publication, to decide whether they can be transformed into International Standards. Technical Reports of type 3 do not necessarily have to be reviewed until the data they provide are considered to be no longer valid or useful.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

ISO/IEC TR 18047-6, which is a Technical Report of type 3, was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 31, *Automatic identification and data capture techniques*.

This second edition cancels and replaces the first edition (ISO/IEC TR 18047-6:2006), which has been technically revised.

ISO/IEC TR 18047 consists of the following parts, under the general title *Information technology — Radio frequency identification device conformance test methods*:

- *Part 2: Test methods for air interface communications below 135 kHz*
- *Part 3: Test methods for air interface communications at 13,56 MHz*
- *Part 4: Test methods for air interface communications at 2,45 GHz*
- *Part 6: Test methods for air interface communications at 860 MHz to 960 MHz*
- *Part 7: Test methods for active air interface communications at 433 MHz*

Introduction

ISO/IEC 18000 defines the air interfaces for radio frequency identification (RFID) devices used in item management applications. ISO/IEC 18000-6 defines the air interface for these devices operating at frequencies from 860 MHz to 960 MHz.

ISO/IEC TR 18047 provides test methods for conformance with the various parts of ISO/IEC 18000.

Each part of ISO/IEC TR 18047 contains all measurements required to be made on a product in order to establish whether it conforms to the corresponding part of ISO/IEC 18000. For this part of ISO/IEC TR 18047, each interrogator needs to be assessed for operation with both types A and B, while each tag is only required to support at least one of the types A or B or C.

NOTE Measurement of tag and interrogator performance is covered by ISO/IEC 18046.

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Information technology — Radio frequency identification device conformance test methods —

Part 6: Test methods for air interface communications at 860 MHz to 960 MHz

1 Scope

This part of ISO/IEC TR 18047 defines test methods for determining the conformance of radio frequency identification (RFID) devices (tags and interrogators) for item management with the specifications given in ISO/IEC 18000-6, but does not apply to the testing of conformity with regulatory or similar requirements.

The test methods require only that the mandatory functions, and any optional functions which are implemented, be verified. This may, in appropriate circumstances, be supplemented by further, application-specific functionality criteria that are not available in the general case.

The interrogator and tag conformance parameters in this part of ISO/IEC TR 18047 are the following:

- type-specific conformance parameters including nominal values and tolerances;
- parameters that apply directly affecting system functionality and inter-operability.

The following are not included in this part of ISO/IEC TR 18047:

- parameters that are already included in regulatory test requirements;
- high-level data encoding conformance test parameters (these are specified in ISO/IEC 15962).

Unless otherwise specified, the tests in this part of ISO/IEC TR 18047 are to be applied exclusively to RFID tags and interrogators defined in ISO/IEC 18000-6.

Clause 5 describes all necessary conformance tests.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO/IEC 18000-6, *Information technology — Radio frequency identification for item management — Part 6: Parameters for air interface communications at 860 MHz to 960 MHz*

ISO/IEC 19762 (all parts), *Information technology — Automatic identification and data capture (AIDC) techniques — Harmonized vocabulary*

ISBN 92-67-10188-9, 1993, *ISO Guide to the expression of uncertainty in measurement*

3 Terms, definitions, symbols and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO/IEC 19762 apply.

3.2 Symbols

For the purposes of this document, the symbols given in ISO/IEC 19762 and the following apply.

D	Modulation depth of data coding pulse
d1	Distance between the interrogator and test antenna
d2	Distance between test antenna and EUT tag
ds	Distance between the interrogator antenna and sense antenna
dT,IA	Interrogator antenna to tag distance
dT,MA	Measurement antenna to tag distance
dTE	Distance between the interrogator antenna and tag emulator
G1	Interrogator antenna gain
GIA	Gain of interrogator antenna
GMA	Gain of measurement antenna
K	Calibration factor
L	Maximum interrogator antenna dimension
M	Modulation index
PI	Delivered power at the carrier frequency
PM	Measured power at the carrier frequency
Tf	Fall time
Tr	Rise time

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3.3 Abbreviated terms

For the purposes of this document, the abbreviated terms given in ISO/IEC 19762 and the following apply.

DUT	Device under test
EUT	Equipment under test
RCS	Radar cross-section
Δ RCS	Change in radar cross-section
RBW	Resolution bandwidth
VBW	Video bandwidth

3.4 Default conditions applicable to the test methods

3.4.1 Test environment

Unless otherwise specified, testing shall take place in an environment of temperature $23\text{ °C} \pm 3\text{ °C}$ and of non-condensing humidity from 40 % to 60 %.

3.4.2 Pre-conditioning

Where pre-conditioning is required by the test method, the identification tags to be tested shall be conditioned to the test environment for an appropriate time period, which shall be recorded.

3.4.3 Default tolerance

Unless otherwise specified, a default tolerance of $\pm 5\%$ shall be applied to the quantity values given to specify the characteristics of the test equipment (e.g. linear dimensions) and the test method procedures (e.g. test equipment adjustments).

3.4.4 Noise floor at test location

Noise floor at test location shall be measured with the spectrum analyser in the same conditions as for the measurement of the EUT, with a span of 10 MHz: RBW, VBW and antenna.

The spectrum analyser shall be configured in acquisition for at least 1 minute.

The maximum of the measured amplitude shall be 20 dB below the value of the amplitude of the measured tag backscatter operating at minimum power ($P_{I,\min}$, see clause 5.2.2.2), and the tag placed at 10λ from the measurement antenna.

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Special attention has to be given to spurious emissions, e.g. insufficiently shielded computer monitors. The electromagnetic test conditions of the measurements shall be checked by performing the measurements with and without a tag in the field.

3.4.5 Total measurement uncertainty

The total measurement uncertainty for each quantity determined by these test methods shall be stated in the test report.

NOTE Basic information is given in *ISO Guide to the expression of uncertainty in measurement*, ISBN 92-67-10188-9, 1993.

4 Setup of test equipment

4.1 Setup of test equipment for interrogator tests

4.1.1 General

The EUT shall be an interrogator including an antenna.

All conformance measurements and setups shall be done in an anechoic chamber as defined in Annex A.

Dependent of the regulatory requirements all measurements shall be done at one of the test frequencies in Table 1.

Table 1 — Test frequencies

Test carrier frequency	Comment
866 MHz	Recommended for tests under European regulations
910 MHz	Recommended for tests under Korean or US regulations
922 MHz	Recommended for tests under Australian regulations
953 MHz	Recommended for tests under Japan regulations

NOTE With the test frequencies specified in Table 1 all frequencies of the entire band from 860 MHz to 960 MHz are within $\pm 2,5\%$ of one of the test frequencies.

4.1.2 Sense antenna

Where applicable, tests shall be carried out using a sense antenna, which shall be a substantially non-reactive non-radiating load of $50\ \Omega$ equipped with an antenna connector. The Voltage Standing Wave Ratio (VSWR) at the $50\ \Omega$ connector shall not be greater than 1,2 : 1 over the frequency range of the measurement.

4.1.3 Test apparatus and test circuits for ISO/IEC 18000-6 Type A and B interrogator

4.1.3.1 Interrogator modulation test setup

For this test the sense antenna shall always be placed and orientated for optimum field strength reception in the direction of the major power radiation of the interrogator antenna according Figure 1 at a distance d_s which is defined in clause 5.1.1.2.

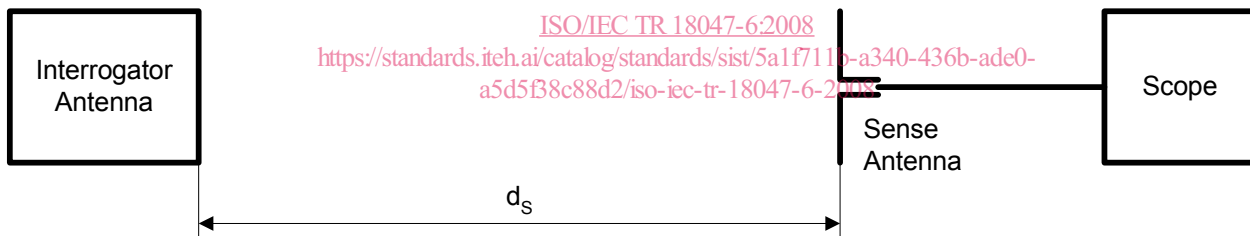


Figure 1 — Interrogator modulation test setup

4.1.3.2 Interrogator demodulation and turn around time test setup

For this test the tag emulator as defined in Annexe F shall be placed and orientated for optimum field strength reception in the direction of the major power radiation of the interrogator according Figure 2 at a distance d_{TE} , which is defined in clause 5.1.2.2.

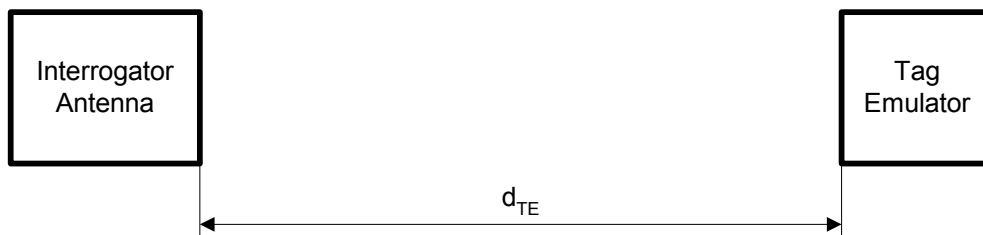


Figure 2 — Interrogator demodulation and turn around test setup

4.1.4 Test apparatus and test circuits for ISO/IEC 18000-6 Type C interrogator

The EUT shall be an interrogator including an antenna.

For this test, the sense antenna shall always be placed according to Figure 3. The distance between an interrogator antenna and a sense antenna shall be d_1 . The sense antenna shall be placed in the optimum orientation so as to receive the highest possible power level radiated by the interrogator antenna.

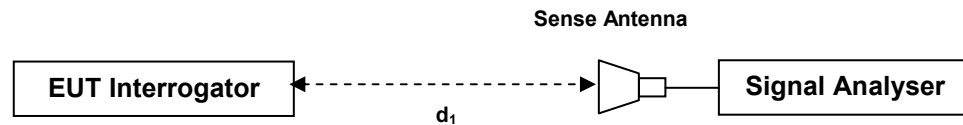


Figure 3 — Interrogator test setup

For some interrogator tests a tag emulator as defined in Annex F shall be used, the tag emulator shall be placed and orientated for optimum field strength reception in the direction of the major power radiation of the interrogator.

4.2 Setup of test equipment for tag tests

4.2.1 General

The EUT shall be a tag including all means in order to be capable to communicate with an interrogator.

When tests require use of an interrogator this shall be an interrogator including antenna that conforms to ISO/IEC 18000-6 according to the methods defined in this Type of ISO/IEC TR 18047, or it shall be a signal generator including antenna. Furthermore, the interrogator shall support the minimum tag response to interrogator command turn around time.

The interrogator antenna shall fulfil the specification of Table 2.

Table 2 — Interrogator antenna requirements for tag tests

Symbol	Parameter	Minimum Value	Maximum Value
L	Maximum Interrogator antenna dimension	0,1 m	$\sqrt{\frac{\lambda d_T}{2}}$
G_1	Interrogator antenna gain	2 dBi	8 dBi

All conformance measurements and setups shall be done in an anechoic chamber as defined in Annex A.

Dependent of the regulatory requirements all measurements shall be done at either of the test frequencies in Table 1.

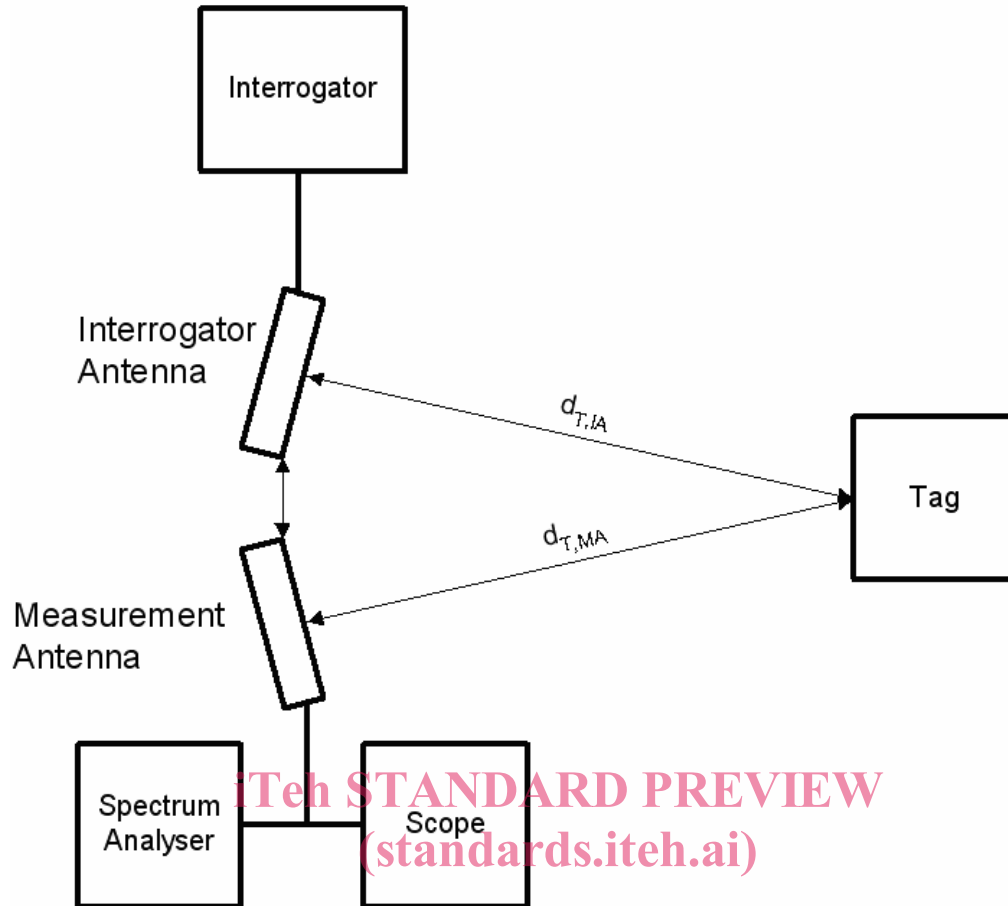
4.2.2 Test apparatus and test circuits for ISO/IEC 18000-6 Type A and B tags

4.2.2.1 Tag demodulation and turn around time test setup

For this test the tag shall be placed and oriented for optimum field strength reception in the direction of the major power radiation of the interrogator in a distance

$$d_{T,IA} > \frac{2L^2}{\lambda}, \quad d_{T,MA} > \frac{2L^2}{\lambda}$$

with L being the maximum dimension of the interrogator antenna according Figure 4.



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Figure 4 — Tag demodulation test setup

4.2.2.2 Tag backscatter test setup

For this test the test interrogator antenna setup, where the interrogator may alternately also be realized with a vector signal generator according Annex H, shall consist of a set of two mechanically assembled antennas specifically designed to reduce the signal coupling between each other. One shall be used as interrogator antenna while the second, shall be used as measurement antenna and shall be connected either to a spectrum analyser or to an oscilloscope as specified according to Annex D.

The main lobe axis of these two antennas cross each other with an angle value that shall be lower than 15°. The tag under test shall be placed at this focal point and oriented for optimum field strength reception.

The distances between the tag and the antennas are $d_{T,IA}$ and $d_{T,MA}$ respectively (see Figure 4).

The tag backscatter test setup parameters are defined in Table 3.

Table 3 — Tag backscatter setup parameters

Symbol	Name	Description
$d_{T,IA}$	Interrogator antenna to tag distance	
$d_{T,MA}$	Measurement antenna to tag distance	
G_{IA}	Gain of interrogator antenna	The maximum 3 dB beam width shall be $\pm 35^\circ$
G_{MA}	Gain of measurement antenna	The maximum 3 dB beam width shall be $\pm 35^\circ$

The residual signal coupling between the two antennas shall be measured in free space, and anechoic or similar RF absorbing material shall be used between two antennas to increase isolation up to 45 dB in the value in free space is not better than 45 dB.

L shall be the greater value of the Interrogator and Measurement Antenna.

The spectrum analyser shall be to a RBW of 30 kHz, a VBW of 100 kHz. The minimum span should be at least 1 MHz or 8 times the data rate, whichever is greater. The frequency analyser shall use max peak detection.

For this test the tag shall be setup to provide only one modulation frequency. Therefore the tag shall except for the preamble, only reply with a bit stream of zero data bits.

4.2.2.3 Tag response time

The setup for this test shall be as described in chapter 4.2.2.1.

4.2.2.4 Tag bit rate accuracy test setup

The setup for this test shall be as described in chapter 4.2.2.1.

4.2.2.5 Tag state storage time test setup

The setup for this test shall be as described in chapter 4.2.2.1.

4.2.3 Test apparatus and test circuits for ISO/IEC 18000-6 Type C tags

The EUT shall be a tag including all means in order to be capable to communicate with an interrogator.

For this test the tag shall be placed and oriented for optimum field strength reception in the direction of the major power radiation of the interrogator in a distance

$$d_{T,IA} > \frac{2L^2}{\lambda}, \quad d_{T,MA} > \frac{2L^2}{\lambda}$$

with L being the maximum dimension of the interrogator antenna according to Figure 4.

The test antenna must be linearly polarized and with VSWR <1:1.5.

5 Conformance tests for ISO/IEC 18000-6 Type A

5.1 Functional tests of interrogator

5.1.1 Interrogator modulation test

5.1.1.1 Test objective

The objective of this test is to verify that the interrogator provides the appropriate modulation waveform required for operation of tags.

5.1.1.2 Test procedure

The interrogator shall transmit an **Init_round_all** command at the maximum power allowed under the regulations of the selected carrier frequency for testing.

In case the interrogator is intended for operation of non-overlapping RF bands, then this test shall be done for each RF band.

Measurements shall be done with a sense antenna positioned at a distance $d_S = 3 \lambda$ and $d_S = 10 \lambda$ and for each operation mode.

A digital oscilloscope as specified in Annex D and the sense antenna shall be used to record the waveform provided by the interrogator.

5.1.1.3 Test report

The test report shall give the measured values of the parameters according Table 4 The pass/fail condition is determined whether the measured values are within the requirements as specified in ISO/IEC 18000-6. Furthermore, the EUT and the sense antenna orientation and position, as well as the used interrogator output power and the used operation frequency shall be recorded.

Table 4 — Measurements to be made

Parameter	Conditions
D	Default modulation operation mode
Tapr	Default modulation operation mode
Tapf	Default modulation operation mode

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5.1.2 Interrogator demodulation and turn around time

5.1.2.1 Test objective

The objectives of this test are to verify whether the interrogator is capable of

- demodulating signals from the tags,
- receiving the data transmitted by the tag emulator after the minimum specified turn-around time.

5.1.2.2 Test procedure

The interrogator shall transmit an **Init_round_all** command (see clause B.1.1) at the maximum power allowed under the regulations of the selected carrier frequency for testing.

After the command provided by the interrogator has been sent and after the minimum turn around time, a tag emulator as specified in Annex F shall transmit a typical response to the **Init_round_all** command at a minimum Δ RCS specified in ISO/IEC 18000-6 Tag: 7d. The tag emulator does not need to demodulate the command, but shall only detect its end to respond after the minimum turn-around time.

When the interrogator is intended for operation of non-overlapping RF bands this test shall be done for each RF band.

Measurements shall be done with a tag emulator positioned at $d_{TE} = 10 \lambda$ for both the minimum and maximum tag response data rate, i.e. the turn around time from interrogator command to tag response.

In case the interrogator is design for shorter communication distances, then the distance d_{TE} may be decreased and the actual used value shall be mentioned in test report.

The interrogator (digital) demodulator shall accept the tag response including verification of the CRC.

5.1.2.3 Test report

The test report shall contain the tag emulator distance to the interrogator and the Δ RCS value setup in the tag emulator. Furthermore, also the set up turnaround time from the tag emulator, the EUT and the tag emulator orientation and position, as well as the used interrogator output power and the used operation frequency shall be recorded.

5.2 Functional tests of tag

5.2.1 Tag demodulation and turn around time

5.2.1.1 Test objective

The objectives of this test are to verify whether the tag is capable of

- demodulating signals from the interrogator,
- receiving the data transmitted by the interrogator after the minimum specified response to command turn-around time.

5.2.1.2 Test procedure

The test interrogator shall transmit an **Init_round_all** (see clause B.1.1) command.

The tag (EUT) shall receive the command provided by the interrogator and shall provide an appropriate response. After complete reception of the tag response the interrogator shall generate a **Next_slot** command within the minimum specified turn around time between tag response and interrogator command.

Measurements shall be done by verifying that the tag detected the command appropriately by means of evaluation of its response. Measurements shall be done at $P_{I,1}$ or the minimum tag activation power density $S_{T,min}$ for each operation type of the interrogator command and data rate.

The power density $S_{T,min}$ is related to the test interrogator radiated power $P_{I,min}$ as following:

$$P_{I,min} = 4\pi d_{T,IA}^2 S_{T,min} \frac{1}{G_{IA}}$$

In case the interrogator is design for shorter communication distances, then the distance d_{TE} may be decreased and the actual used value shall be mentioned in test report.

The test shall be seen as successful, when it could be shown that the tag sent the correct response for both commands including verification of the CRC.

The interrogator waveform shall contain the setups of the waveform for the respective types according to Table 5.

Table 5 — Setups of waveforms

Setup number	Setup description	Parameter setting
A-1	Minimum modulation depth	D = Dmin
A-2	Medium modulation depth	D = (Dmax + Dmin)/2
A-3	Maximum modulation depth	D = Dmax